

Advanced technical education in the age of cyber physical systems

Vierhaus, Heinrich Theodor; Schölzel, Mario; **Raik, Jaan; Ubar, Raimund-Johannes** 10th European Workshop on Microelectronics Education : EWME 2014 : May 14-16, 2014, Tallinn, Estonia 2014 / p. 193-198 : ill

Design and test technology for dependable systems-on-chip

2011 https://www.eester.ee/record=b4467408*est

Internationales Doktoranden-Studium : BTU und TU Tallinn konzipieren gemeinsames Doktoranden-Studium

Vierhaus, Heinrich Theodor BTU News : Zeitung der Brandenburgischen Technischen Universität Cottbus 2011 / 34, S. 35 : Fot

Multiple fault testing in systems-on-chip with high-level decision diagrams

Ubar, Raimund-Johannes; Oyeniran, Adeboye Stephen; Schölzel, Mario; Vierhaus, Heinrich Theodor Proceedings of 2015 10th International Design & Test Symposium (IDT) : Dead Sea, Jordan, 14-16 December 2015 2015 / p. 66-71 : ill
<http://dx.doi.org/10.1109/IDT.2015.7396738>

Preface

Ubar, Raimund-Johannes; Raik, Jaan; Vierhaus, Heinrich Theodor Design and test technology for dependable systems-on-chip 2011 / p. xxii-xxviii

Proceedings of the 2011 IEEE Symposium on Design and Diagnostics of Electronic Circuits and Systems : April 13-15, 2011, Gottbus, Germany

2011 <https://www.computer.org/csdl/proceedings/ddecs/2011/12OmNvTBbbs>

RESCUE : cross-sectoral PhD training concept for interdependent reliability, security and quality

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